



120A, 85V N-CHANNEL MOSFET

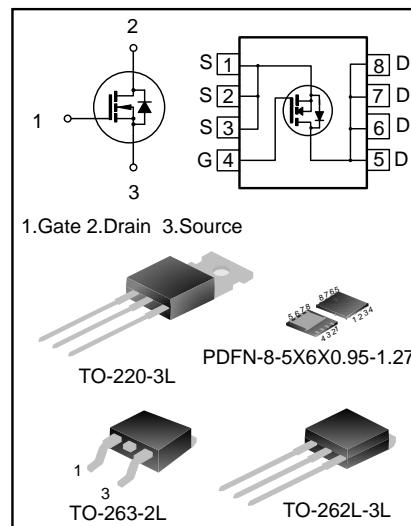
DESCRIPTION

The SVT085R5NT/S/L5/KL is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan's LVMOS technology. The improved process and cell structure have been especially tailored to minimize on-state resistance, provide superior switching performance.

This device is widely used in the fields of uninterruptible power supplies and power management of inverter systems.

FEATURES

- 120A, 85V, $R_{DS(on)(typ.)}=4.5\text{m}\Omega @ V_{GS}=10\text{V}$
- Low gate charge
- Low Crss
- Fast switching
- Improved dv/dt capability



ORDERING INFORMATION

Part No.	Package	Marking	Hazardous Substance Control	Packing Type
SVT085R5NT	TO-220-3L	085R5NT	Pb free	Tube
SVT085R5NS	TO-263-2L	085R5NS	Halogen free	Tube
SVT085R5NSTR	TO-263-2L	085R5NS	Halogen free	Tape&Reel
SVT085R5NL5TR	PDFN-8-5X6X0.95-1.27	085R5NL5	Halogen free	Tape&Reel
SVT085R5NKL	TO-262L-3L	085R5NKL	Pb free	Tube

ABSOLUTE MAXIMUM RATINGS (UNLESS OTHERWISE NOTED, $T_A=25^\circ\text{C}$)

Characteristics	Symbol	Ratings		Unit
		SVT085R5NT/S/KL	SVT085R5NL5	
Drain-Source Voltage	V_{DS}	85		V
Gate-Source Voltage	V_{GS}	± 20		V
Drain Current	I_D	120	100	A
		90	64	
Drain Current Pulsed	I_{DM}	480	400	A
Power Dissipation ($T_c=25^\circ\text{C}$) -Derate above 25°C	P_D	160	114	W
		1.3	0.9	
Single Pulsed Avalanche Energy (Note 1)	E_{AS}	324		mJ
Operation Junction Temperature Range	T_J	-55~+150		$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-55~+150		$^\circ\text{C}$



THERMAL CHARACTERISTICS

Characteristics	Symbol	Ratings		Unit
		SVT085R5NT/S/KL	SVT085R5NL5	
Thermal Resistance, Junction-to-Case	R _{θJC}	0.78	1.1	°C/W
Thermal Resistance, Junction-to-Ambient	R _{θJA}	62.5	50	°C/W

ELECTRICAL CHARACTERISTICS (UNLESS OTHERWISE NOTED, T_J=25°C)

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	85	--	--	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =85V, V _{GS} =0V	--	--	1.0	μA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{GS} =V _{DS} , I _D =250μA	2.0	--	4.0	V
Static Drain- Source On State Resistance	R _{DS(on)}	V _{GS} =10V, I _D =50A	--	4.5	5.5	mΩ
Gate Resistance	R _G	f=1MHz	--	1.9	--	Ω
Input Capacitance	C _{iss}	f=1MHz, V _{GS} =0V, V _{DS} =40V	--	4281	--	pF
Output Capacitance	C _{oss}		--	669	--	
Reverse Transfer Capacitance	C _{rss}		--	17	--	
Turn-on Delay Time	t _{d(on)}	V _{DD} =40V, V _{GS} =10V, R _G =24Ω, I _D =13.3A (Notes 2,3)	--	41	--	ns
Turn-on Rise Time	t _r		--	68	--	
Turn-off Delay Time	t _{d(off)}		--	164	--	
Turn-off Fall Time	t _f		--	85	--	
Total Gate Charge	Q _g	V _{DD} =40V, V _{GS} =10V, I _D =50A (Notes 2,3)	--	68	--	nC
Gate-Source Charge	Q _{gs}		--	28	--	
Gate-Drain Charge	Q _{gd}		--	17	--	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

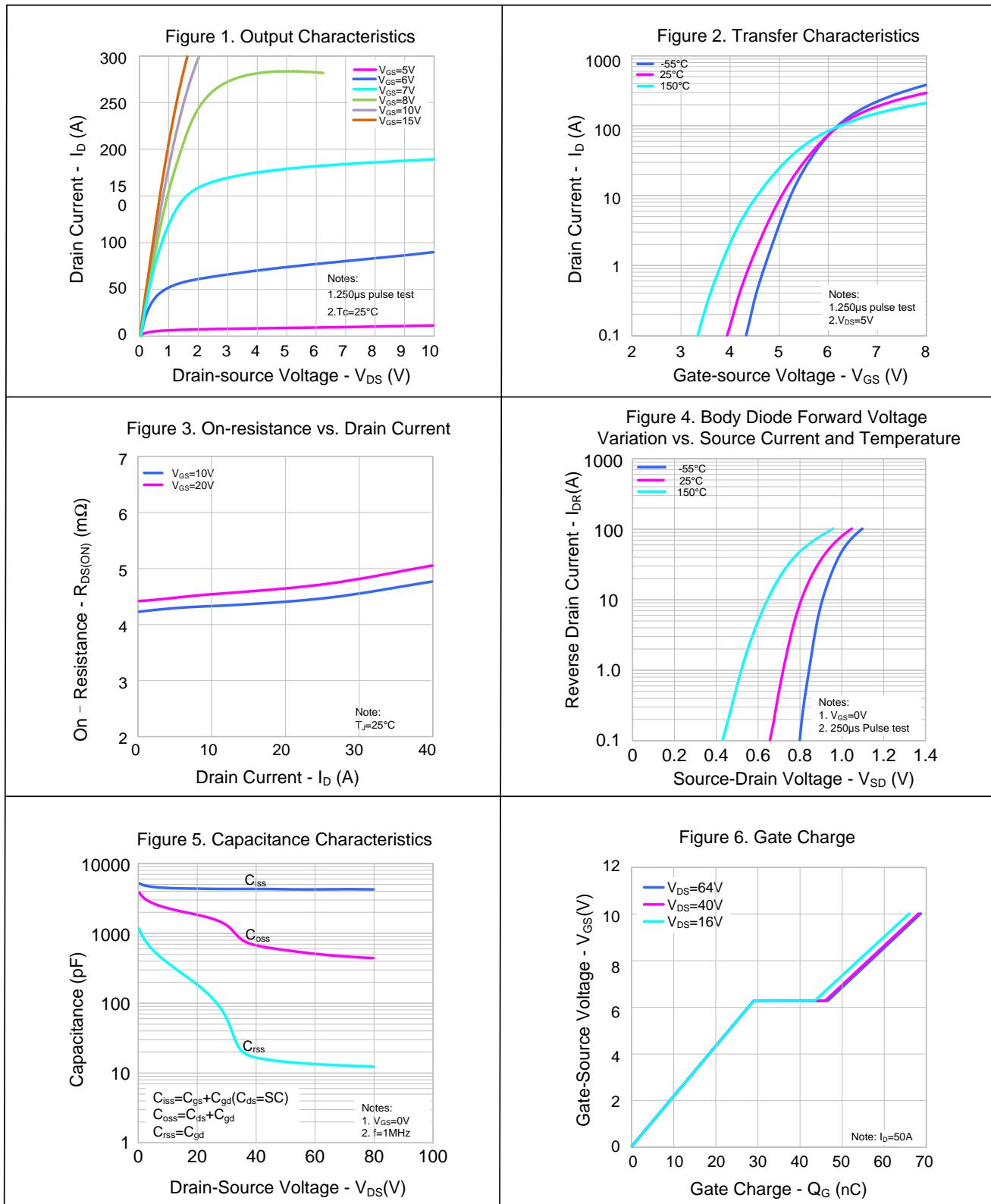
Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I _S	Integral Reverse P-N Junction Diode in the MOSFET	--	--	120	A
Pulsed Source Current	I _{SM}		--	--	480	
Diode Forward Voltage	V _{SD}	I _S =50A, V _{GS} =0V	--	--	1.3	V
Reverse Recovery Time	T _{rr}	I _S =20A, V _{GS} =0V, dI/dt=100A/μs (Notes 2)	--	59	--	ns
Reverse Recovery Charge	Q _{rr}		--	0.12	--	

Notes:

1. L=0.5mH, I_{AS}=36A, V_{DD}=64V, R_G=10Ω, starting T_J=25°C;
2. Pulse Test: Pulse width ≤300μs, Duty cycle≤2%;
3. Essentially independent of operating temperature.

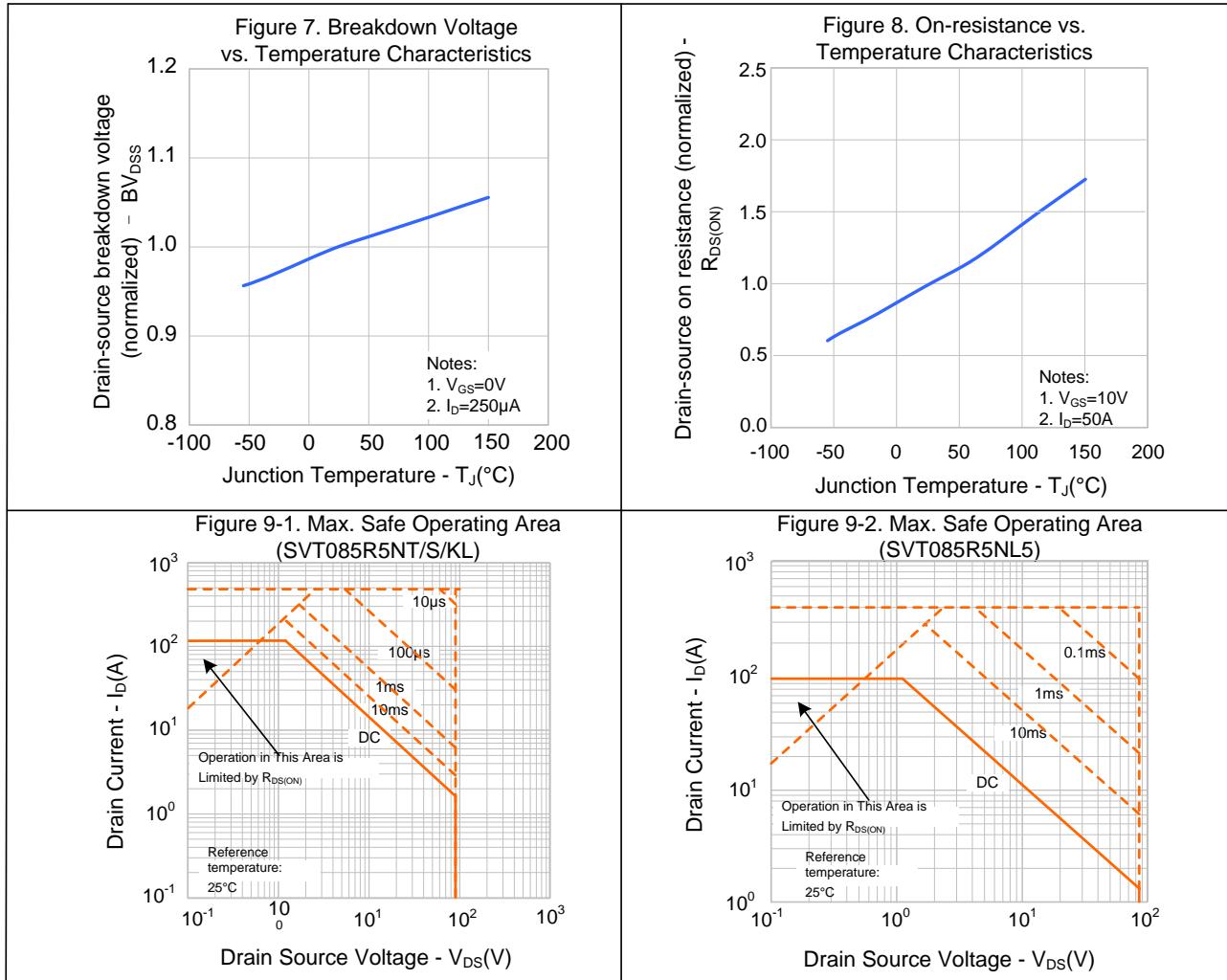


TYPICAL CHARACTERISTICS



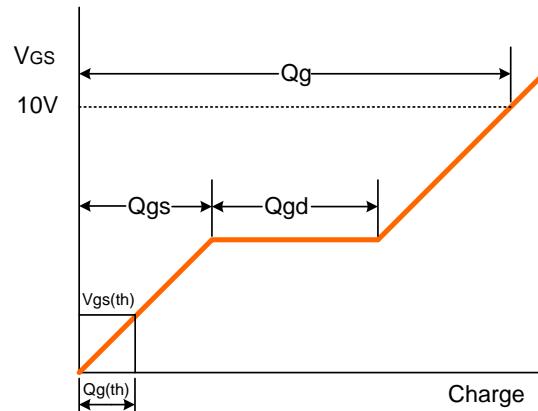
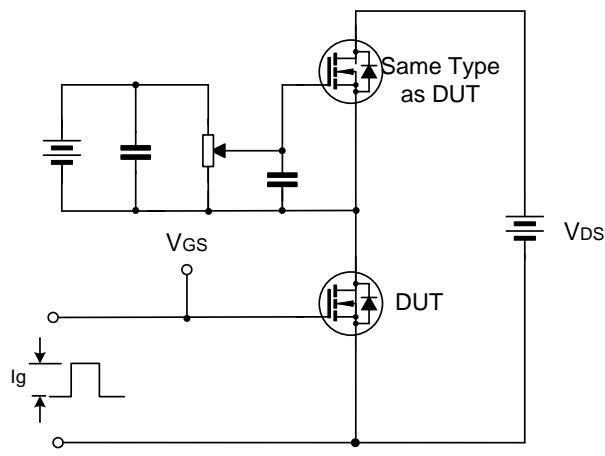


TYPICAL CHARACTERISTICS (CONTINUED)

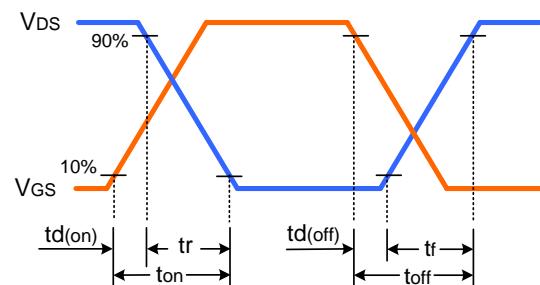
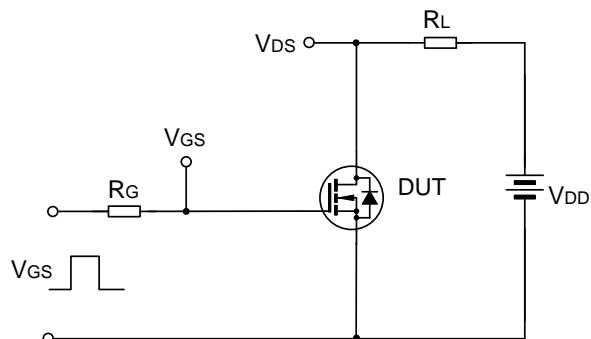


TYPICAL TEST CIRCUIT

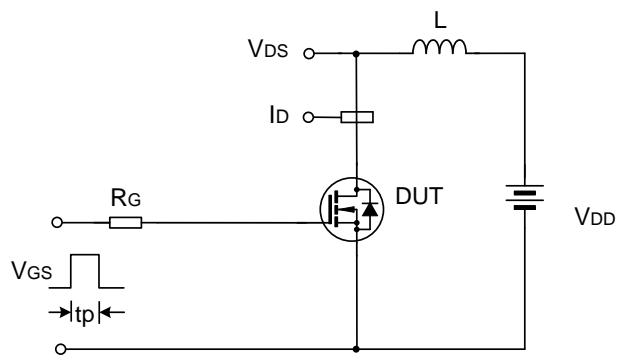
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform



Unclamped Inductive Switching Test Circuit & Waveform



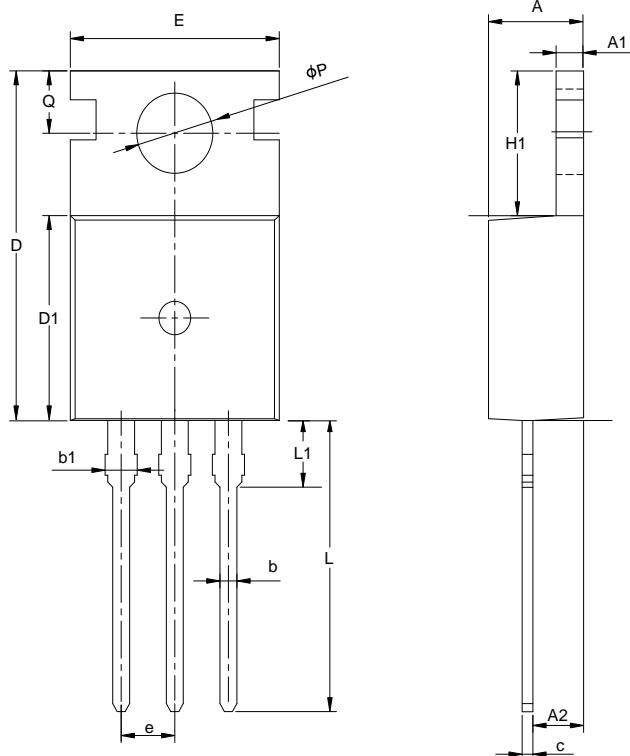
The graph illustrates the transient behavior of a MOSFET. The x-axis is labeled "Time". The y-axis has two labels: BV_{DSS} at the top and V_{DD} at the bottom. A horizontal dashed line at I_{AS} represents the drain current $I_D(t)$. An orange step function shows $V_{DS}(t)$ jumping from V_{DD} to BV_{DSS} at $t = 0$. A blue line shows $I_D(t)$ starting at V_{DD} , increasing linearly to I_{AS} at time tp , remaining constant until $t = tp$, and then decreasing linearly back to V_{DD} . A pink vertical line marks the transition point at $t = tp$.



PACKAGE OUTLINE

TO-220-3L

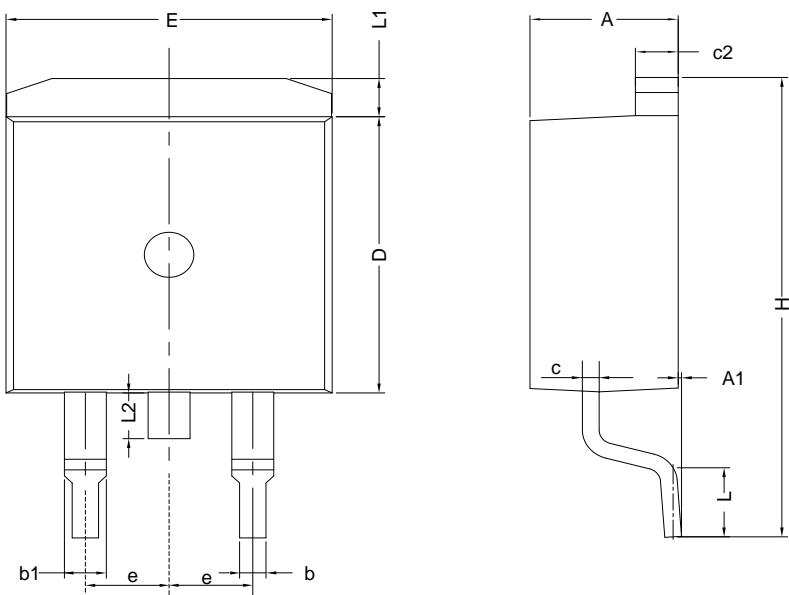
UNIT: mm



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.30	4.50	4.70
A1	1.00	1.30	1.50
A2	1.80	2.40	2.80
b	0.60	0.80	1.00
b1	1.00	—	1.60
c	0.30	—	0.70
D	15.10	15.70	16.10
D1	8.10	9.20	10.00
E	9.60	9.90	10.40
e	2.54BSC		
H1	6.10	6.50	7.00
L	12.60	13.08	13.60
L1	—	—	3.95
φP	3.40	3.70	3.90
Q	2.60	—	3.20

TO-263-2L

UNIT: mm



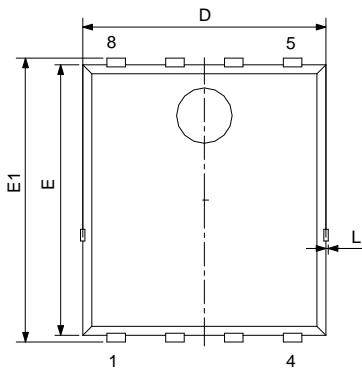
SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.30	4.57	4.72
A1	0	0.10	0.25
b	0.71	0.81	0.91
b1	1.17	—	1.50
c	0.30	—	0.60
c2	1.17	1.27	1.37
D	8.50	—	9.35
E	9.80	—	10.45
e	2.54BSC		
H	14.70	—	15.75
L	2.00	2.30	2.74
L1	1.12	1.27	1.42
L2	—	—	1.75



PACKAGE OUTLINE (CONTINUED)

PDFN-8-5X6X0.95-1.27

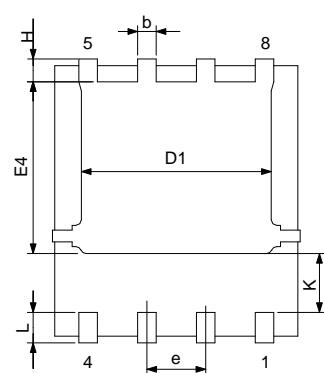
UNIT: mm



Top View



Side View

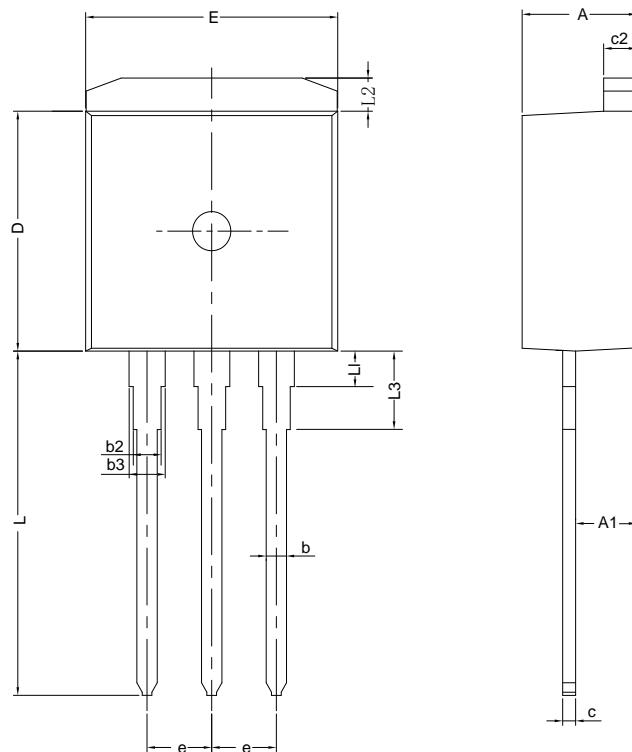


Bottom View

SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	0.90	—	1.20
c	0.154	0.25	0.354
D	4.80	—	5.40
E	5.66	—	6.06
D1	3.76	—	4.30
E1	5.90	—	6.35
b	0.30	—	0.55
K	1.10	1.30	1.50
e	1.07	1.27	1.37
E4	3.34	—	3.92
L	0.30	0.60	0.71
L1	—	—	0.12
H	0.40	—	0.71

TO-262L-3L

UNIT: mm



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.30	4.50	4.70
A1	2.20	—	2.92
b	0.71	0.80	0.88
b2	0.90	1.01	1.08
b3	1.20	—	1.50
c	0.34	—	0.76
c2	1.22	1.30	1.35
D	8.38	—	9.30
E	9.80	10.16	10.54
e	2.54 BSC		
L	12.80	—	14.10
L1	1.40	1.50	1.60
L2	1.12	—	1.42
L3	3.00	3.20	3.40



Important notice :

1. The instructions are subject to change without notice!
2. Customers should obtain the latest relevant information before placing orders and should verify that such information is complete and current. Please read the instructions carefully before using our products, including the circuit operation precautions.
3. Our products are consumer electronic products or the other civil electronic products.
4. When using our products, please do not exceed the maximum rating of the products, otherwise the reliability of the whole machine will be affected. There is a certain possibility of failure or malfunction of any semiconductor product under specific conditions. The buyer is responsible for complying with safety standards and taking safety measures when using our products for system design, sample and whole machine manufacturing, so as to avoid potential failure risk that may cause personal injury or property loss.
5. It is strongly recommended to identify the trademark when buying our products. Please contact us if there is any question.
6. Product promotion is endless, our company will wholeheartedly provide customers with better products!
7. Website: <http://www.silan.com.cn>



Part No.:	SVT085R5NT(S)(L5)(KL)	Document Type:	Datasheet
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Rev.: 1.8

Revision History:

1. Add package of SVT085R5NKL(TO-262L-3L)
2. Update typical test circuit and important notice
3. Update curve template

Rev.: 1.7

Revision History:

1. Update Electrical schematic and typical test circuit

Rev.: 1.6

Revision History:

1. Modify Electrical characteristics and curves

Rev.: 1.5

Revision History:

1. Modify Electrical characteristics

Rev.: 1.4

Revision History:

1. Add the package outline of PDFN-8-5X6X0.95-1.27

Rev.: 1.3

Revision History:

1. Update the Electrical characteristics
2. Update Fig 5 and 6

Rev.: 1.2

Revision History:

1. Update the package outline of TO-220-3L

Rev.: 1.1

Revision History:

1. Add TO-263-2L

Rev.: 1.0

Revision History:

1. First release